

This module is specific for  
Grain Measurement



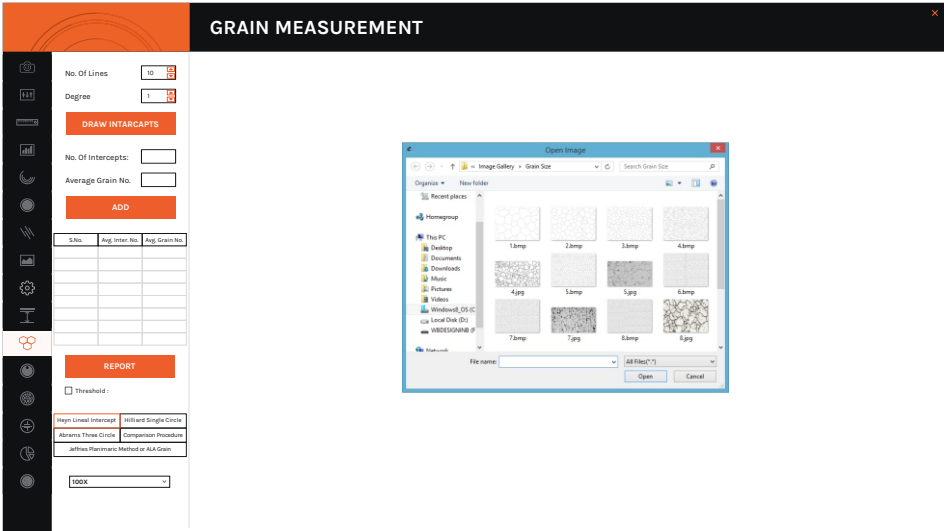
## GRAIN MEASUREMENT

### ABOUT THE GRAIN MEASUREMENT

This method is suitable for poorly etched samples which do not have defined boundaries and are unsuitable for Automatic Line Interception Method.

1st Step

Fig-47



Load the image to be analyzed.

2nd Step

Select the appropriate saved calibration to perform analysis in the image.

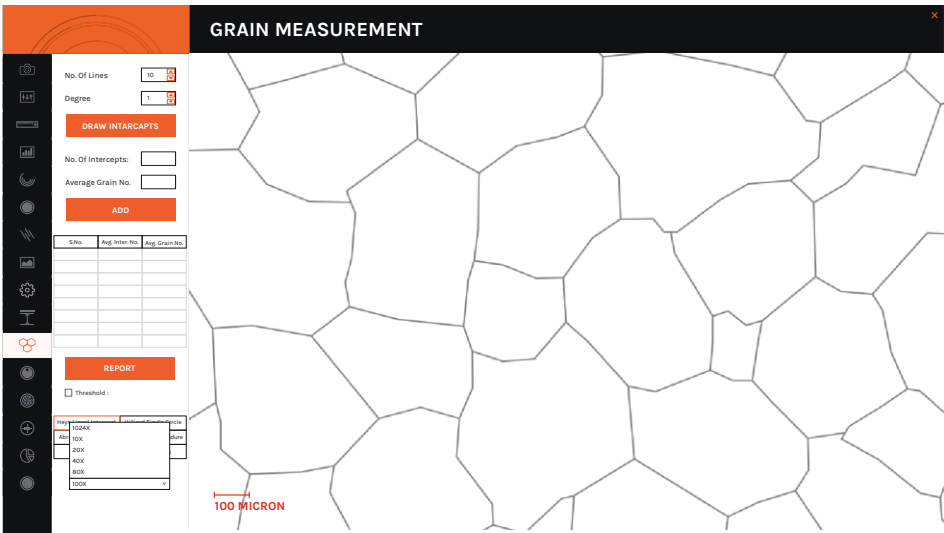
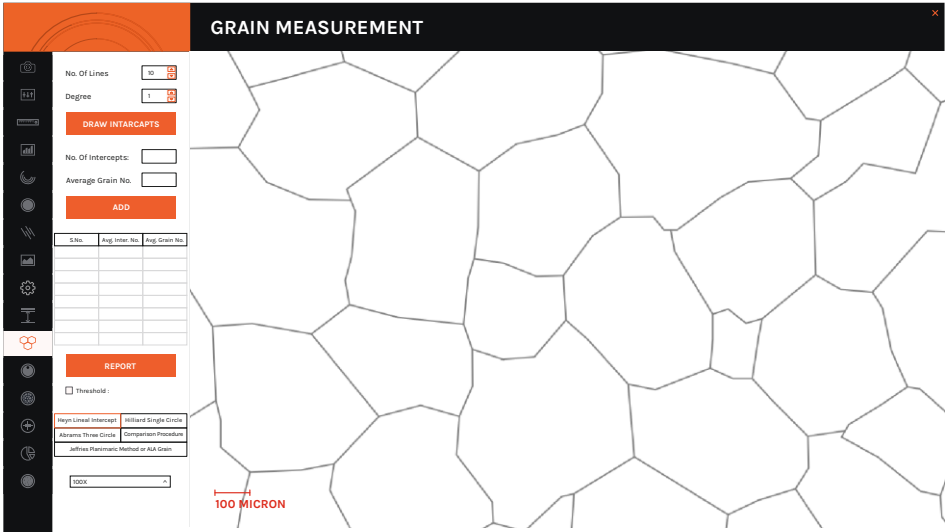


Fig-48

3rd Step

Fig-49



Choose Heyn Lineal Intercept method.

4th Step

Click on threshold.

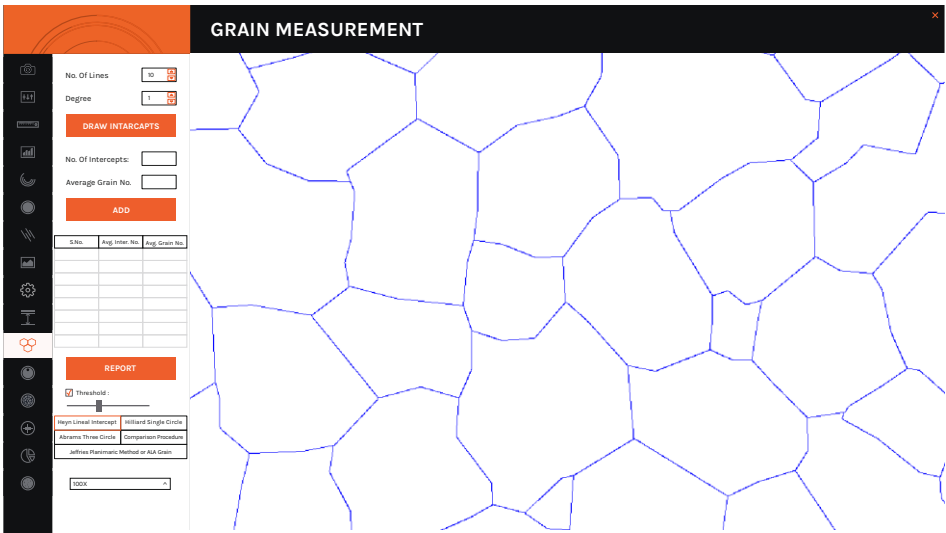
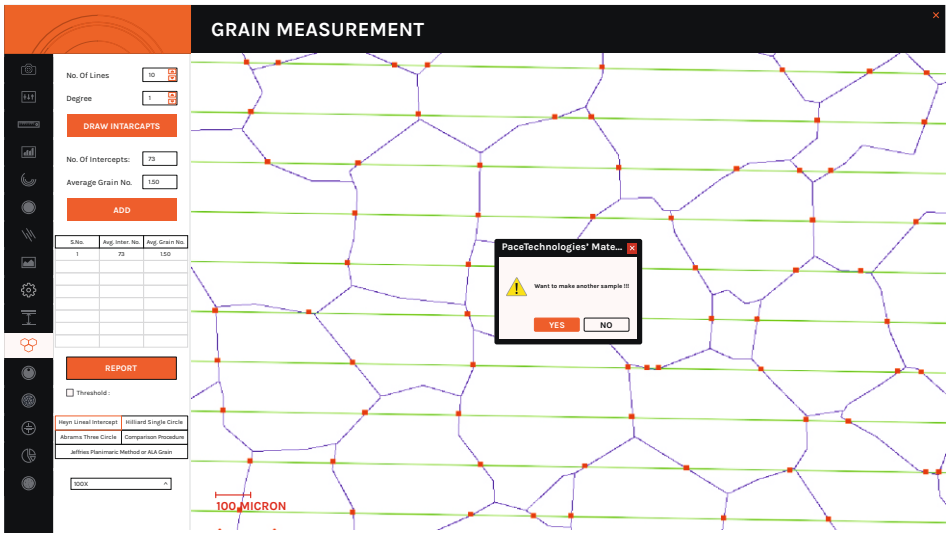


Fig-50

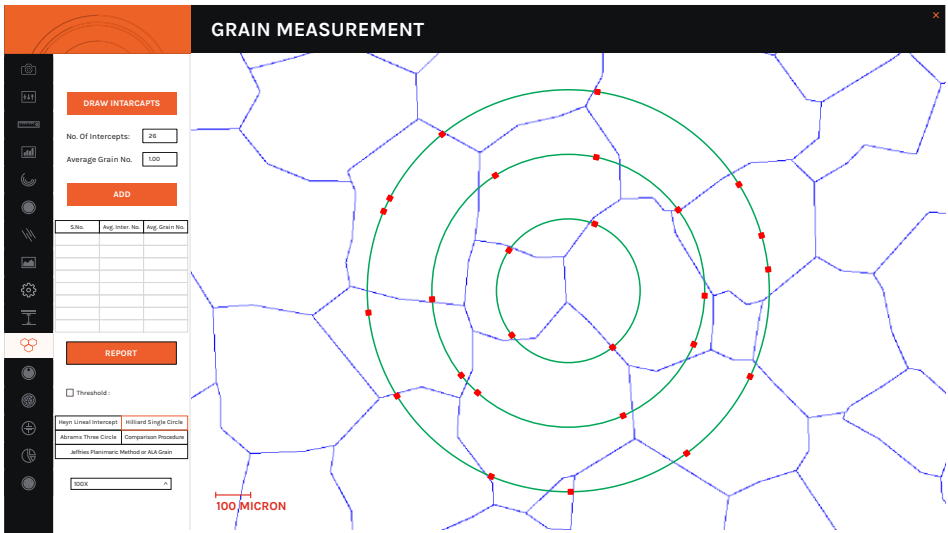


Fig-53

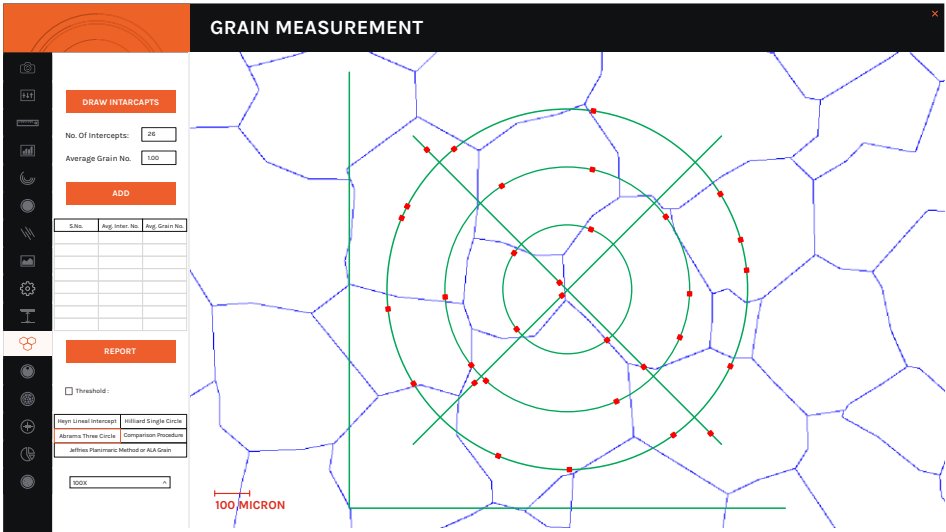


Click on **REPORT** button, message box will ask whether you want to study another field or analysis another captured image. Press **YES** for next picture. Otherwise press **NO** .

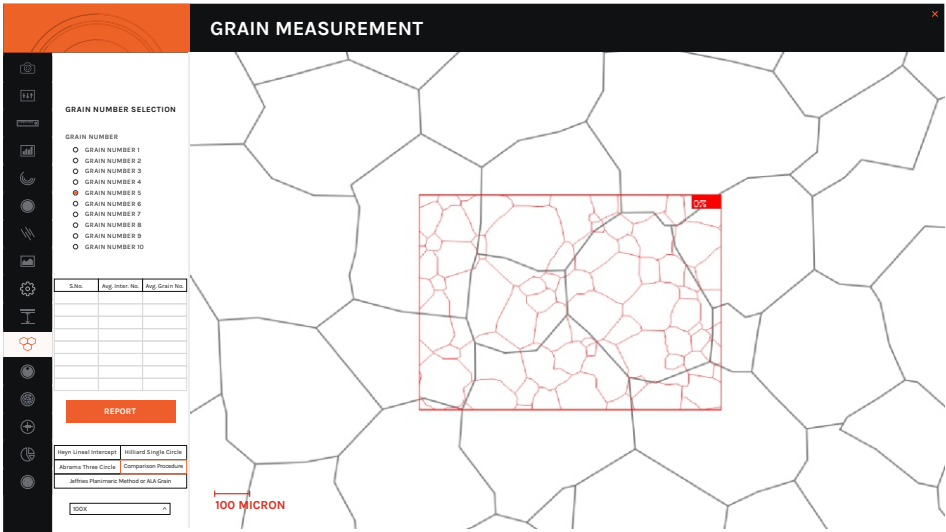
HILLIARD SINGLE CIRCLE



ABRAMS THREE CIRCLE



ABRAMS THREE CIRCLE



## JEFFRIES PLANIMARIC METHOD OR ALA GRAIN

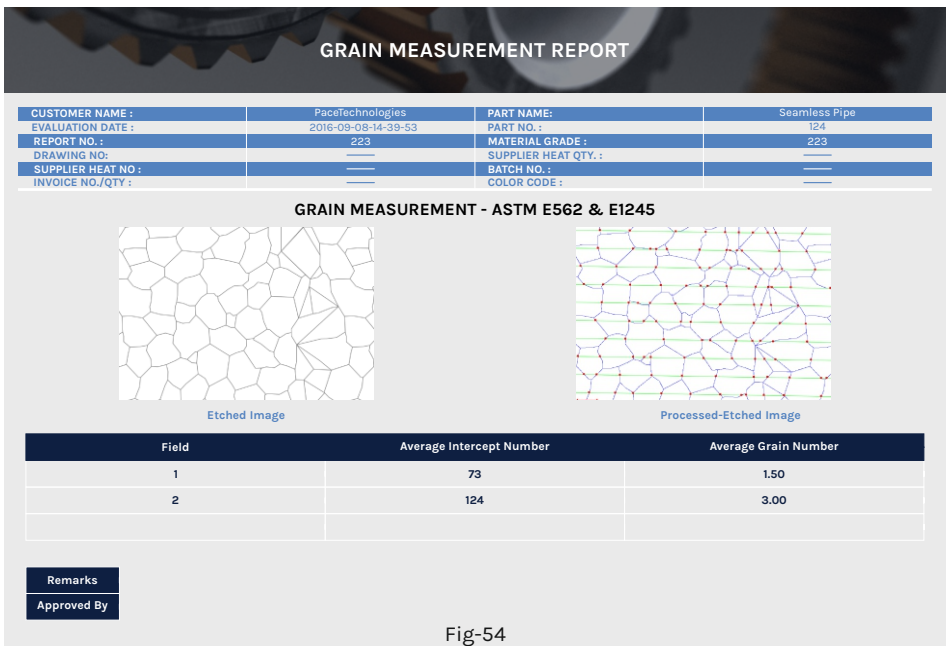
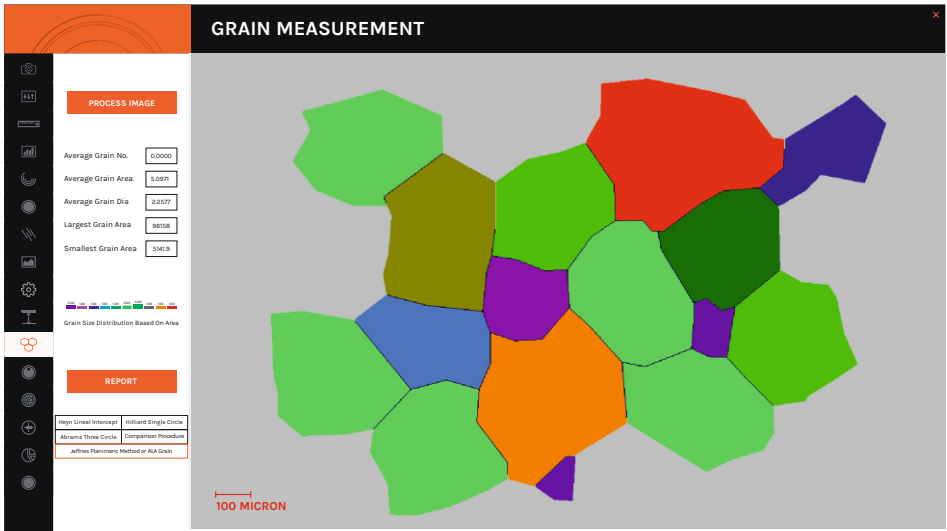


Fig-54